QPA1022D

8.5 – 11 GHz 4 W GaN Power Amplifier

Product Overview

Qorvo's QPA1022D is a MMIC power amplifier fabricated on Qorvo's production 0.15 um GaN on SiC process (QGaN15). Covering 8.5 – 11.0 GHz, the QPA1022D provides > 4 W of saturated output power and 24 dB of large-signal gain while achieving 45% power-added efficiency.

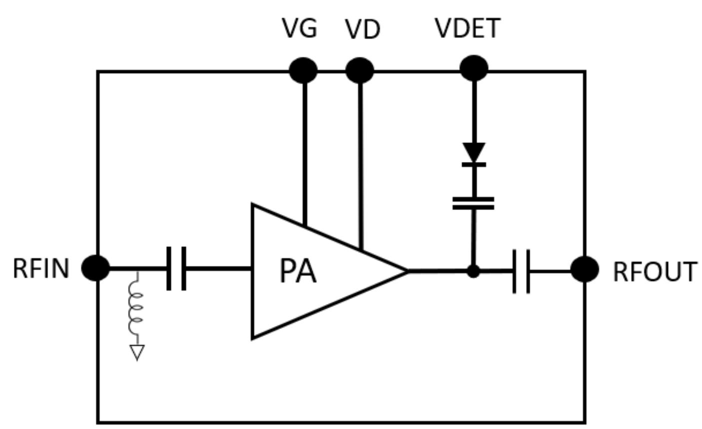
The QPA1022D is matched to 50Ω with integrated DC blocking capacitors at RF output and DC grounded input port. It also has a built-in power detector for system RF power checking. With a compact dimension of 2.65 x 1.25 x 0.10 mm, it can support tight lattice spacing requirements for phased array radar applications. It is also an ideal component to support test instrumentation and commercial communication systems.

Key Features

- Frequency Range: 8.5 – 11 GHz
- P_{SAT} (P_{IN}=12 dBm): 36 dBm
- PAE (P_{IN}=12 dBm): 45 %
- Power Gain (P_{IN}= 12 dBm): 24 dB
- Small Signal Gain: 31 dB
- Bias: V_D = 22 V, I_{DQ} = 180 mA
- Die Dimensions: 2.65 x 1.25 x 0.10 mm

Performance is typical across frequency. Please reference electrical specification table and data plots for more details.

Functional Block Diagram



Applications

- Radar
- Electronic Warfare
- Communications

Ordering Information

Part No.	Description
QPA1022D	8.5 to 11 GHz 4 W GaN Power Amplifier
QPA1022DS2	Device Sample (2 pcs)
QPA1022DEVB	Evaluation Board for QPA1022D

Absolute Maximum Ratings

Parameter	Value / Range	Units
Drain Voltage (V_D)	28	V
Gate Voltage Range (V_G)	-5 to 0	V
Drain Current (I_D)	600	mA
Gate Current (I_G)	10	mA
Input Power (P_{IN}), 3:1 VSWR, V_D=22 V, I_{DQ}=180 mA, 85 °C	27	dBm
Storage Temperature	-55 to +150	°C

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability.

Recommended Operating Conditions

Parameter	Value / Range	Units
Drain Voltage (V_D)	22	V
Drain Current (I_{DQ})	180	mA
Operating Temperature	− 40 to + 85	°C

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Electrical Specifications

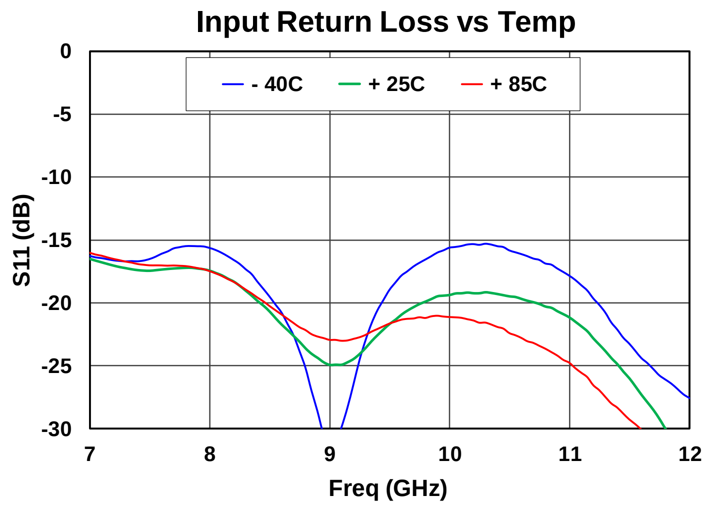
Test conditions unless otherwise noted: Temp = 25 °C, V_D = 22 V, I_{DQ} = 180 mA. Data de-embedded to the reference planes.

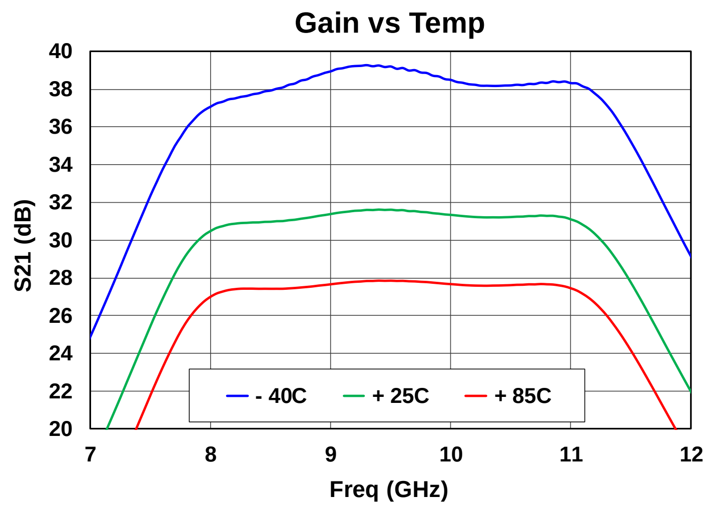
Parameter	Min	Typ	Max	Units
Operational Frequency	8.5		11	GHz
Output Power (Pulse and CW, P_{IN}=12 dBm)		36.5		dBm
Power Added Efficiency (Pulse and CW, P_{IN}= 12 dBm)		45		%
Large Signal Gain (Pulse and CW, P_{IN}=12 dBm)		24.5		dB
Small Signal Gain		31		dB
Input Return Loss		17		dB
Output Return Loss		7		dB
Harmonic Suppression (CW @P_{OUT} = 36 dBm, $2f_0$)		27		dBc
P_{OUT} Temp. Coeff. (P_{IN} = 12 dBm)		−0.001		dB/°C
Small Signal Gain Temp. Coefficient		−0.087		dB/°C

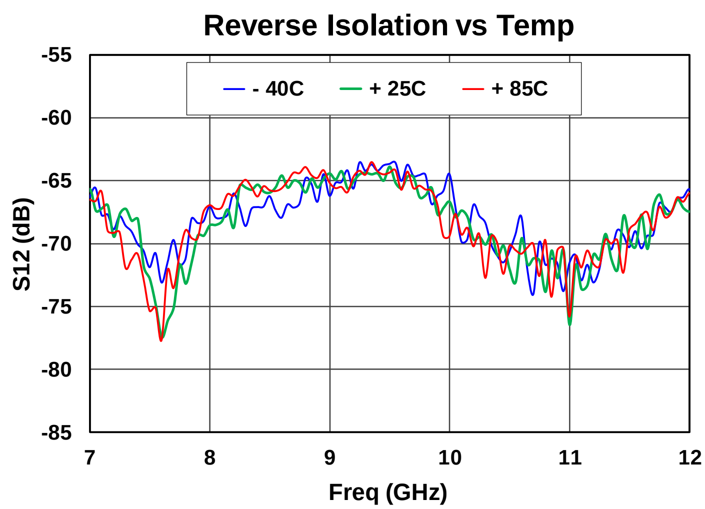
Note: For pulse power, Pulse Width = 100 uS, Duty Cycle = 10%

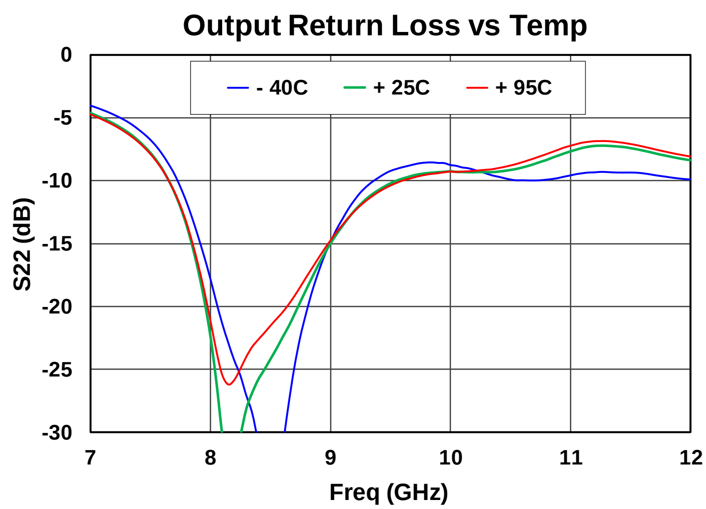
Performance Plots – Small Signal

Test conditions unless otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Temperature = + 25 °C



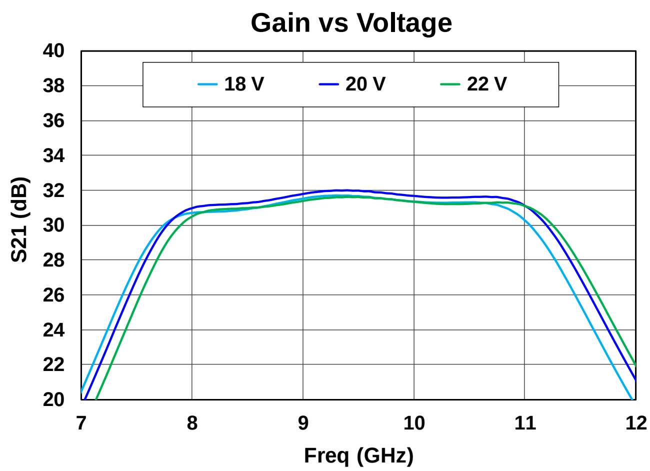


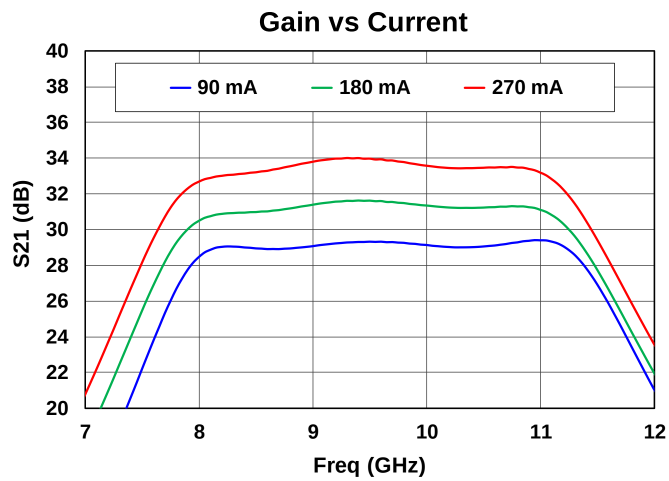


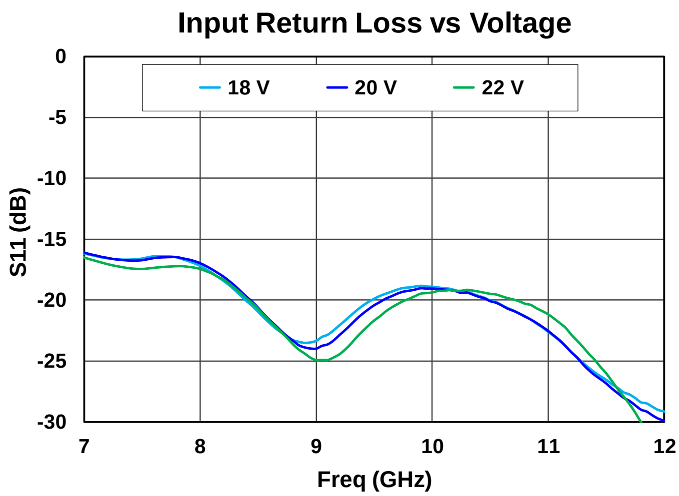


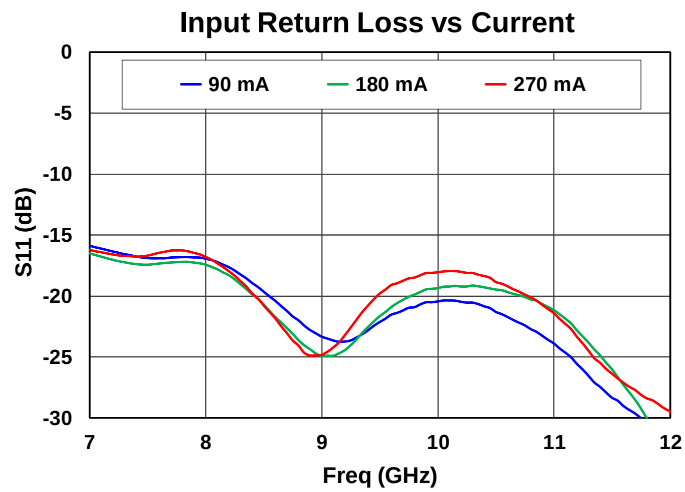
Performance Plots – Small Signal

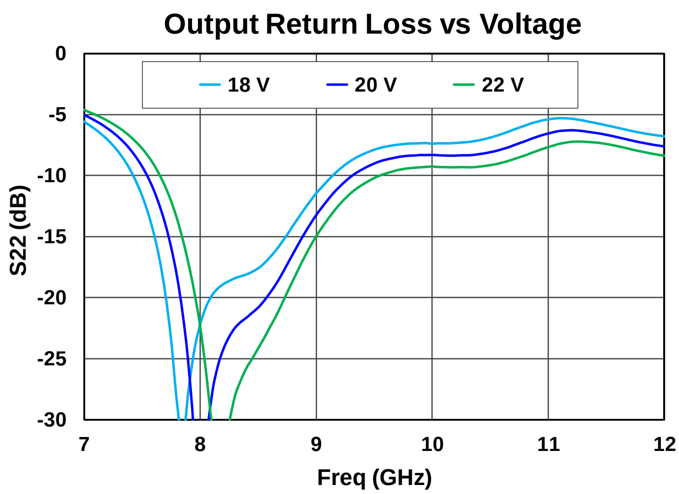
Test conditions unless otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Temperature = + 25 °C

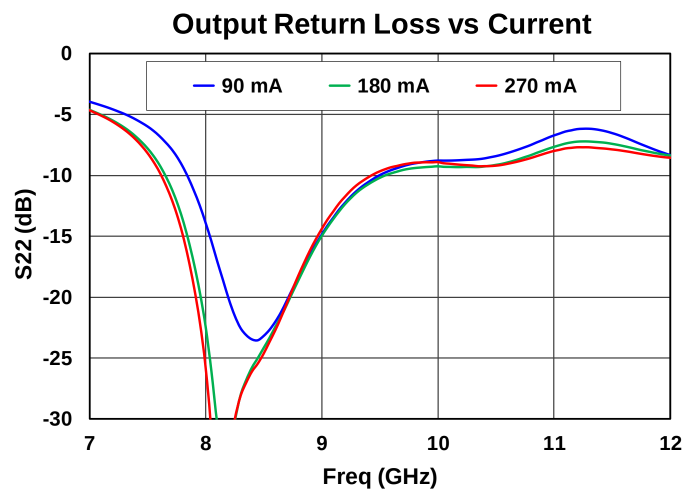






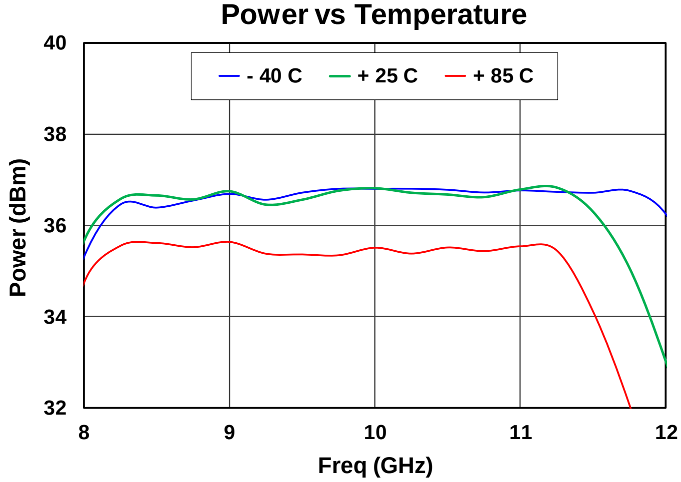


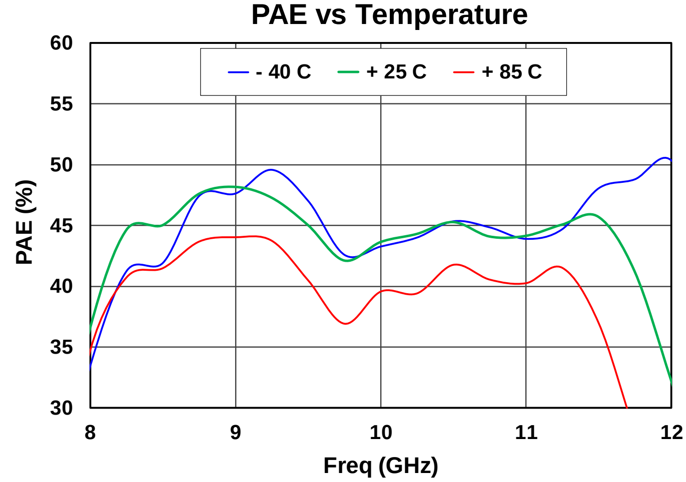


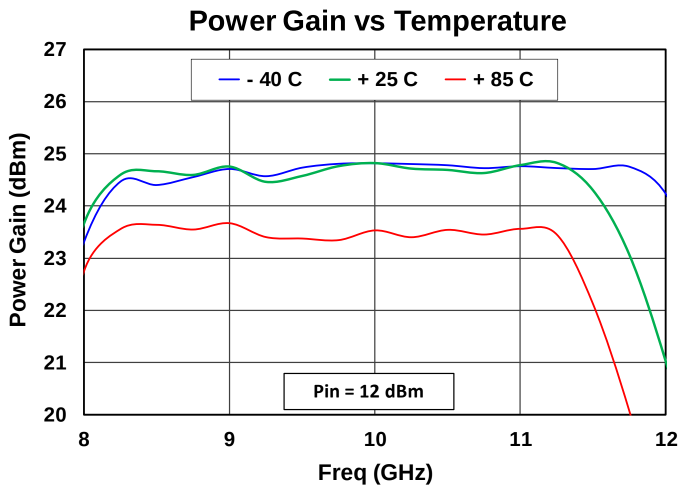


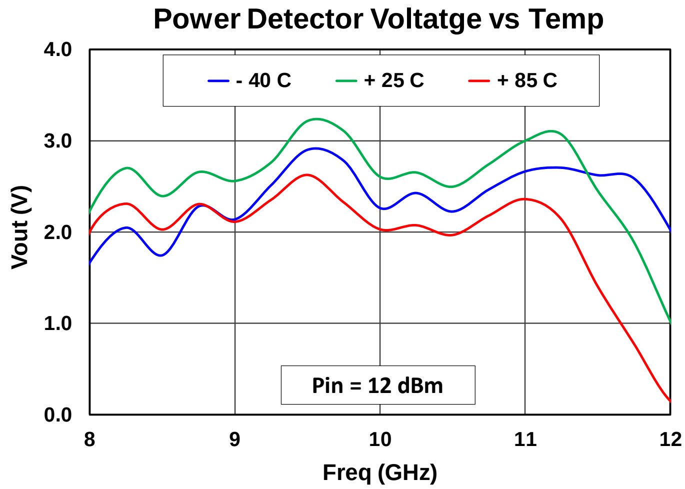
Performance Plots – Large Signal, Pulse

Test conditions unless otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Pin = 12 dBm, Pulse Width = 100 uS, DC = 10%, Temp = + 25 °C









Performance Plots – Large Signal, Pulse

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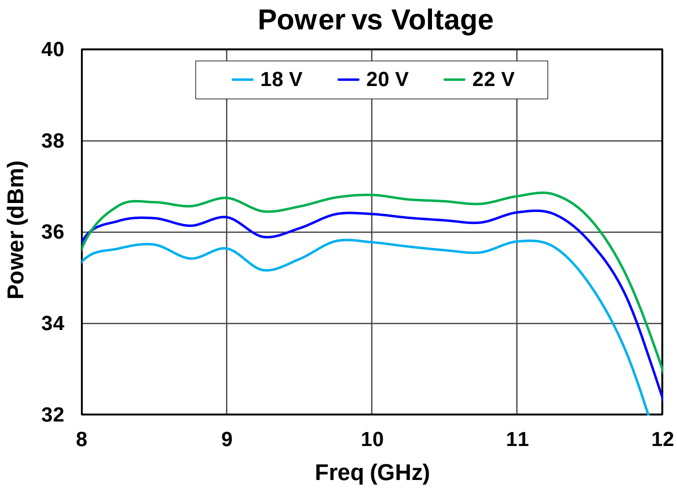
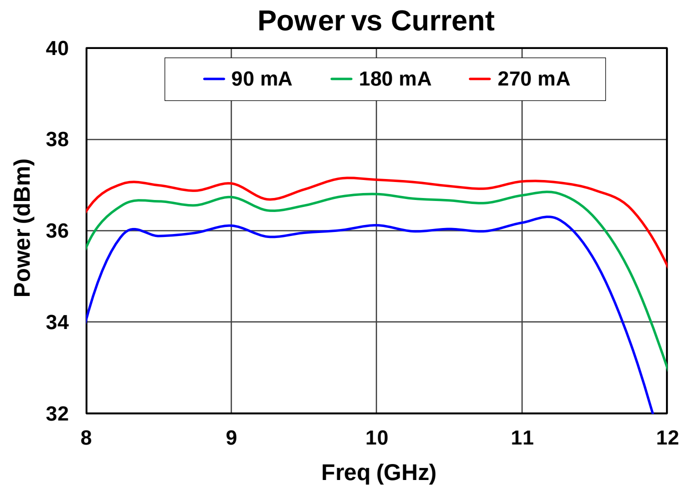
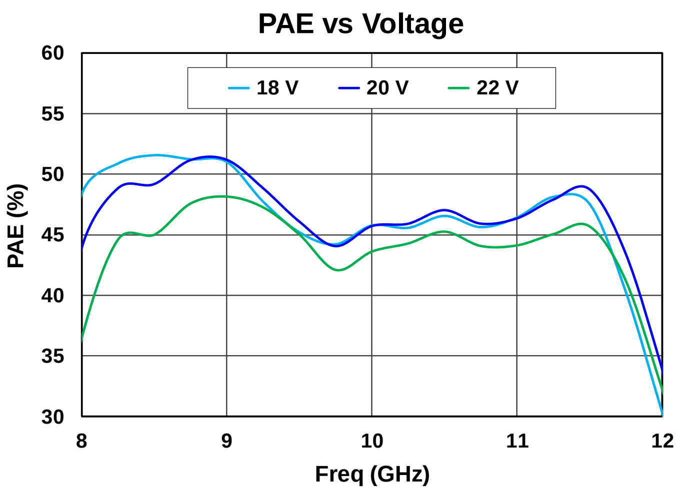
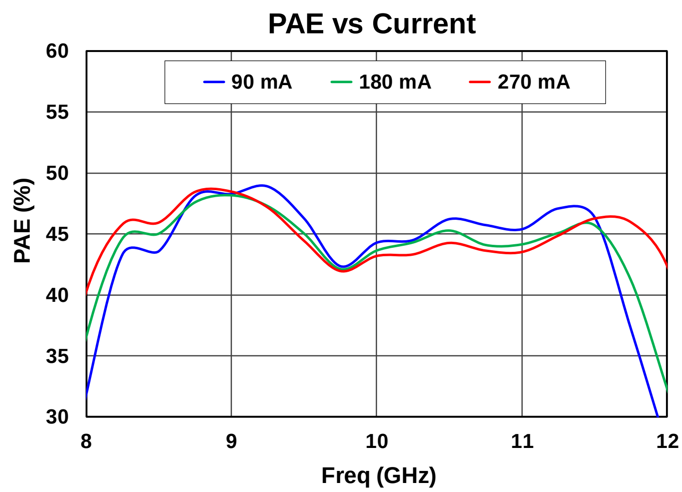
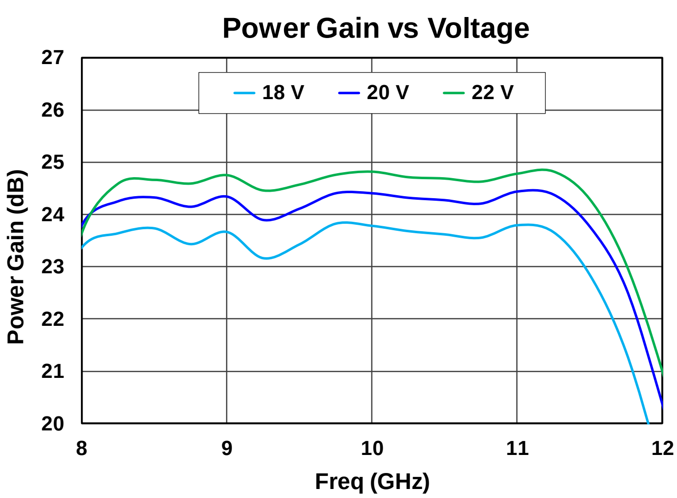
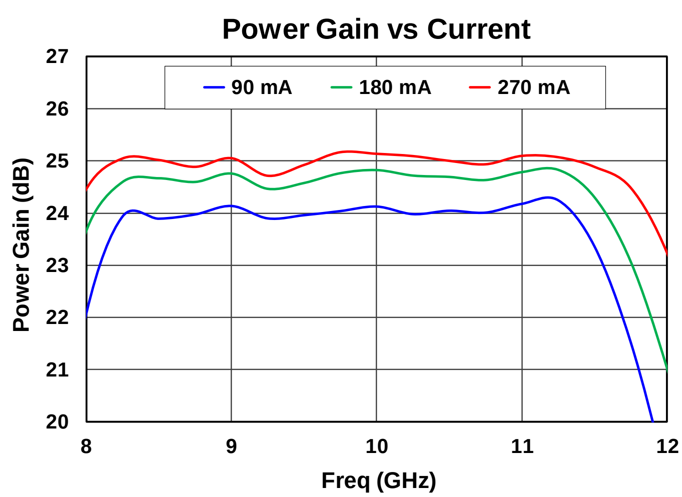








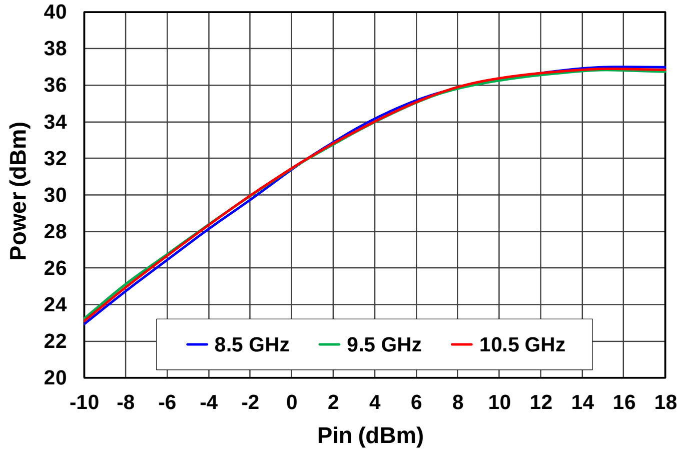




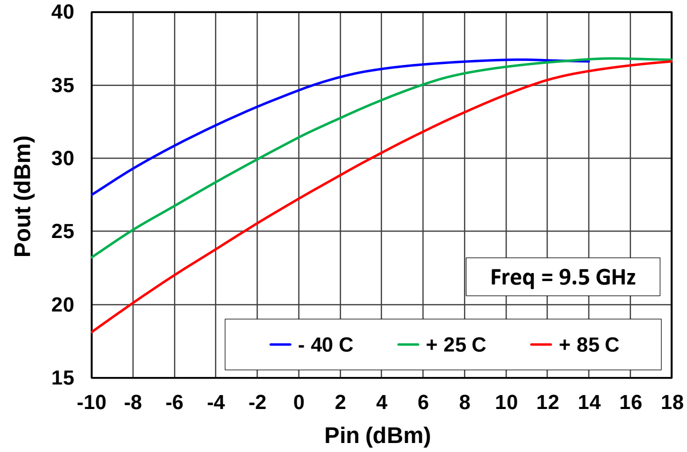
Performance Plots – Large Signal, Pulse

Test conditions unless otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Pin = 12 dBm, Pulse Width = 100 uS, DC = 10%, Temp = + 25 °C

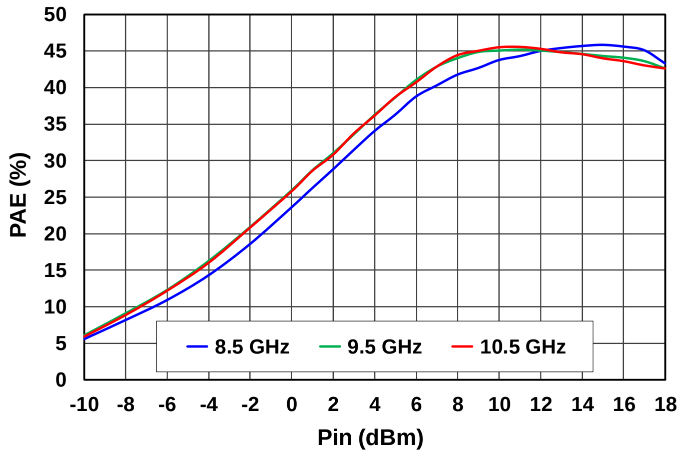
Power vs Pin



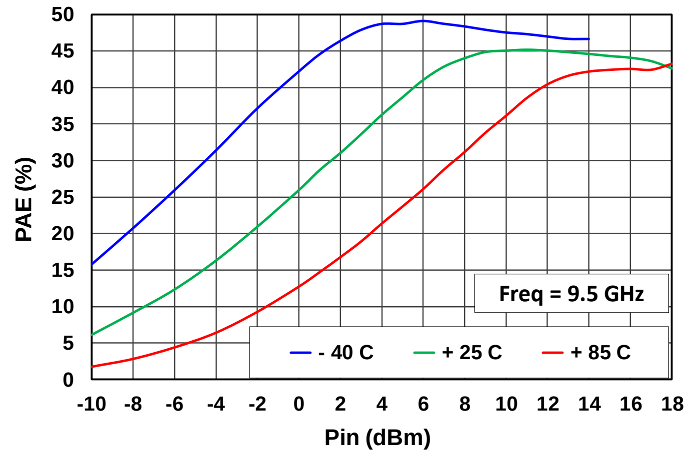
Pout vs Pin vs Temp



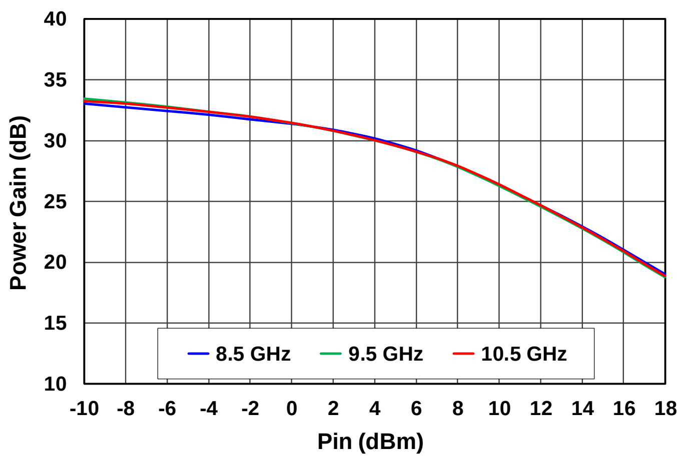
PAE vs Pin



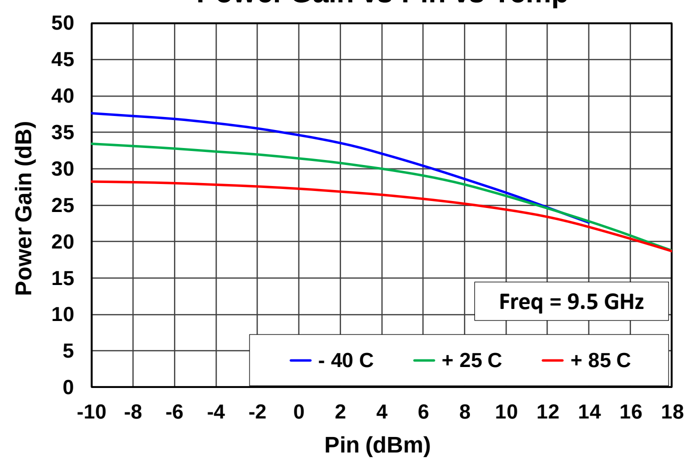
PAE vs Pin vs Temp



Power Gain vs Pin

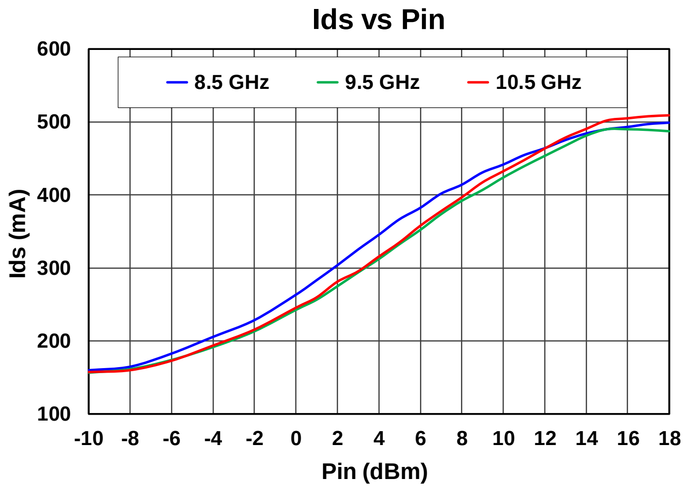


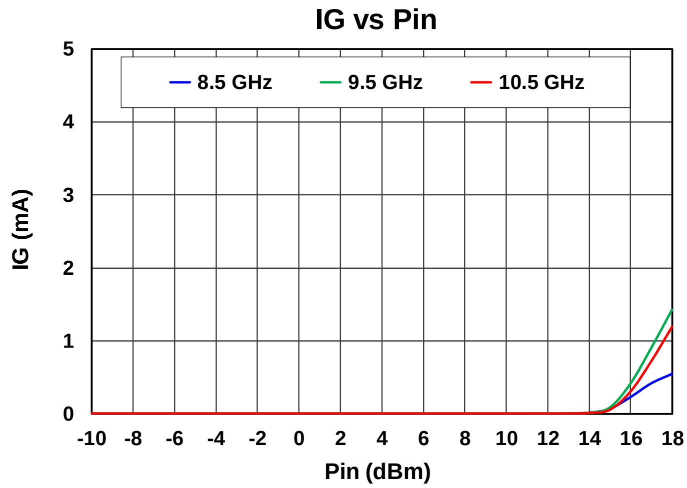
Power Gain vs Pin vs Temp

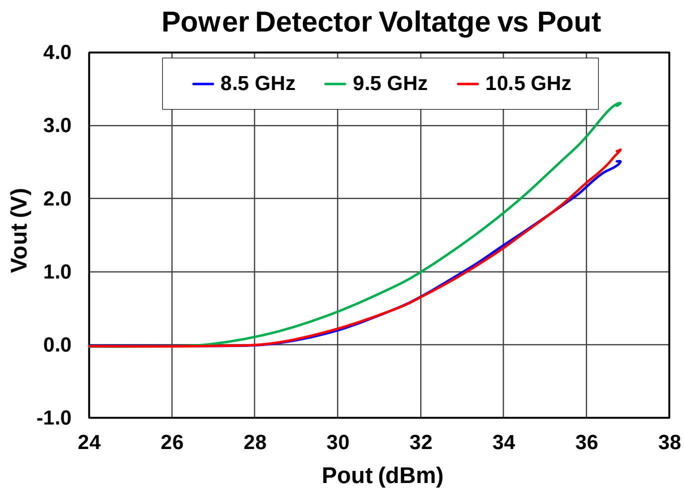


Performance Plots – Large Signal, Pulse

Test conditions unless otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Pin = 12 dBm, Pulse Width = 100 uS, DC = 10%, Temp = + 25 °C

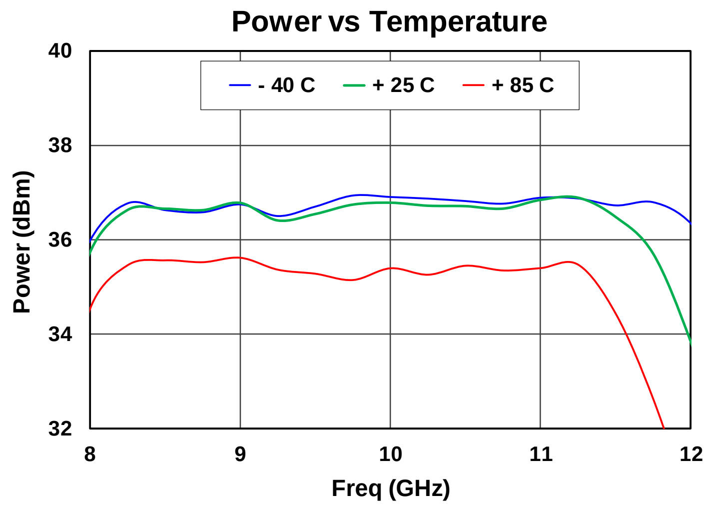


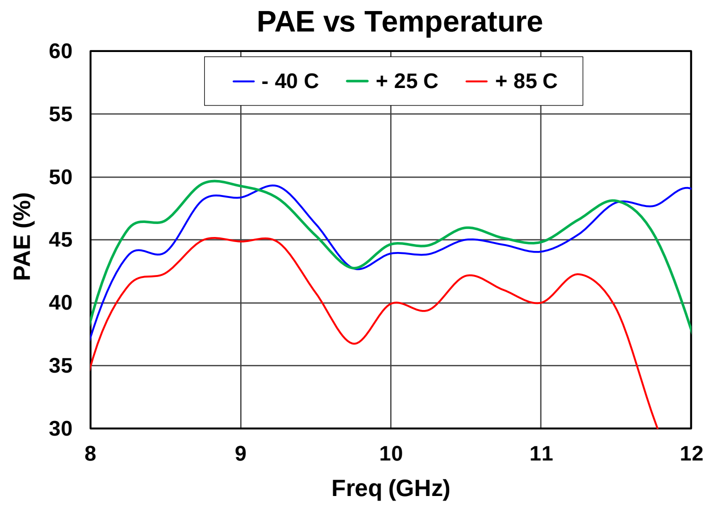


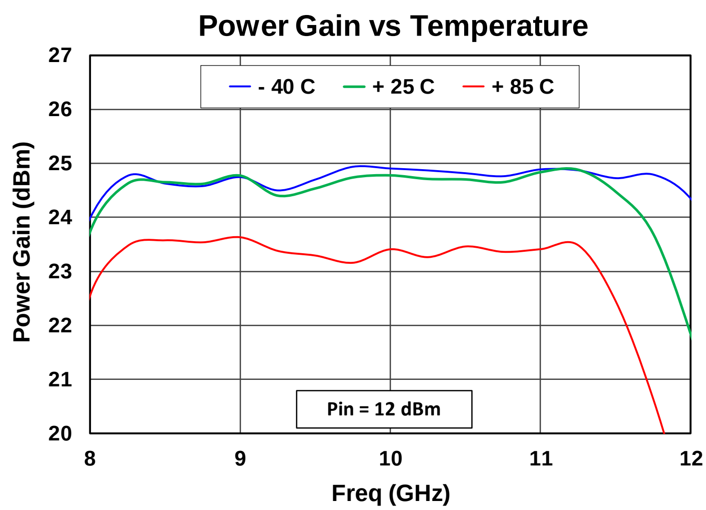


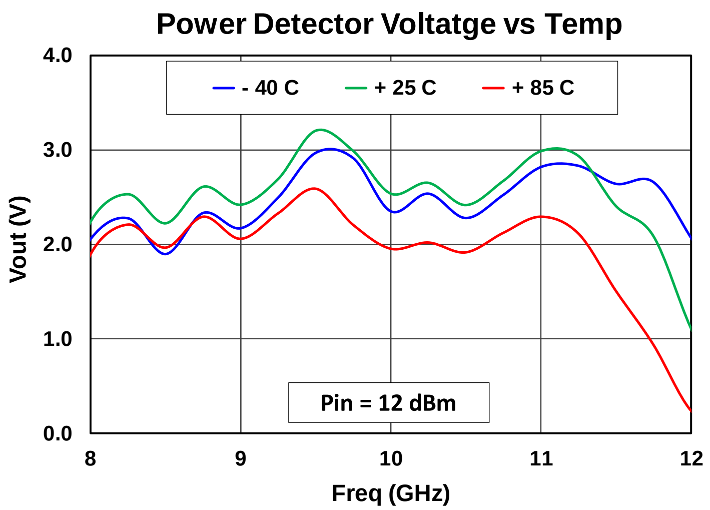
Performance Plots – Large Signal, CW

Test conditions unless otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Pin = 12 dBm, Temperature = + 25 °C





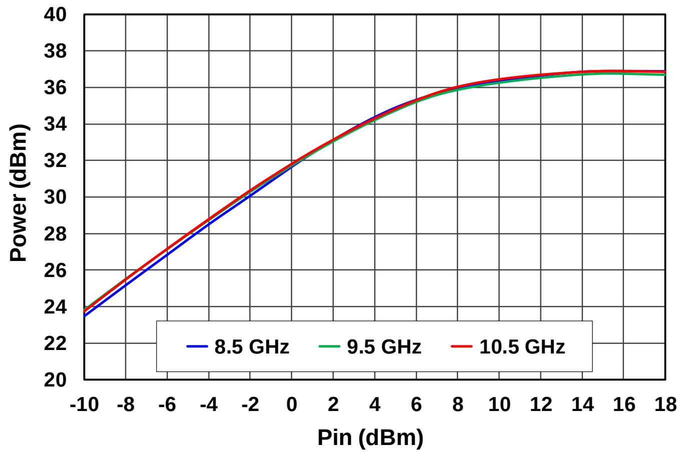




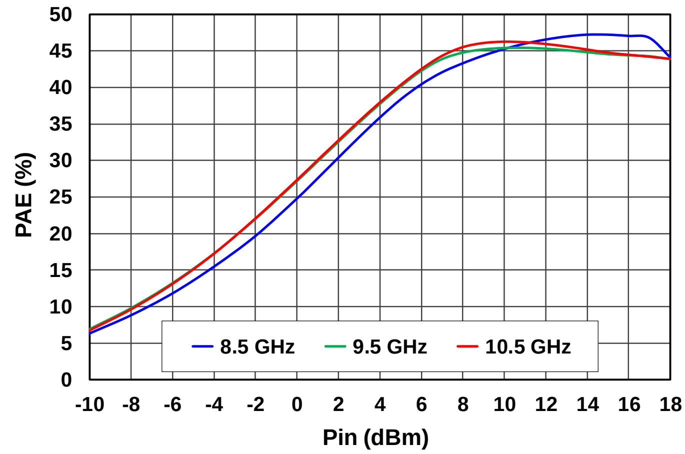
Performance Plots – Large Signal, CW

Test conditions otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Pin = 12 dBm, Temperature = + 25 °C

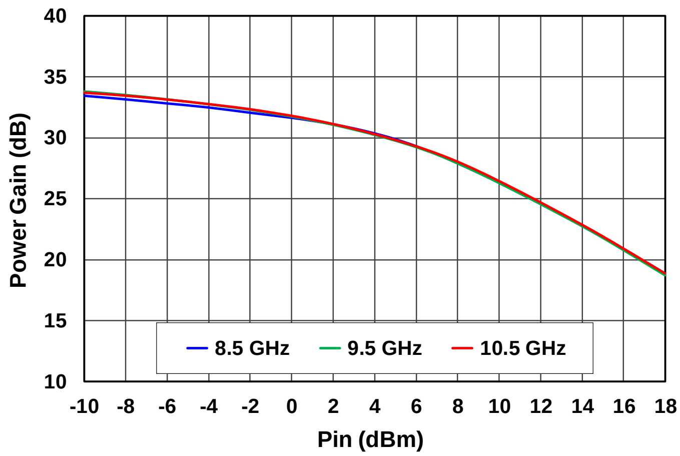
Power vs Pin



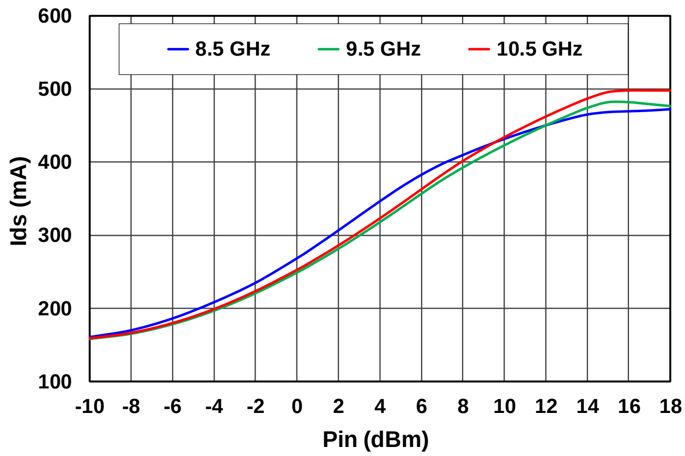
PAE vs Pin



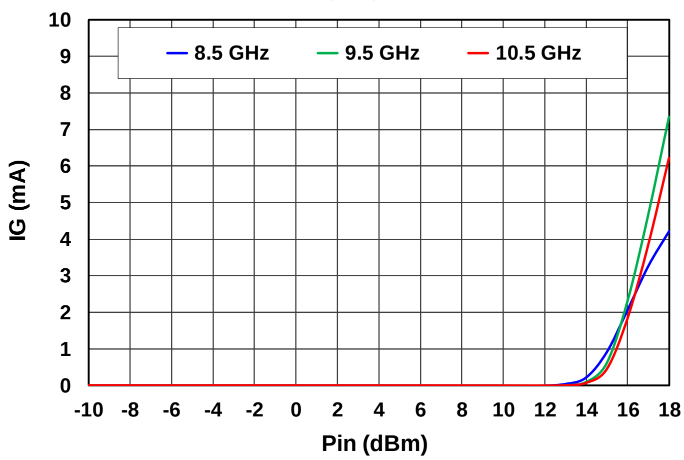
Power Gain vs Pin



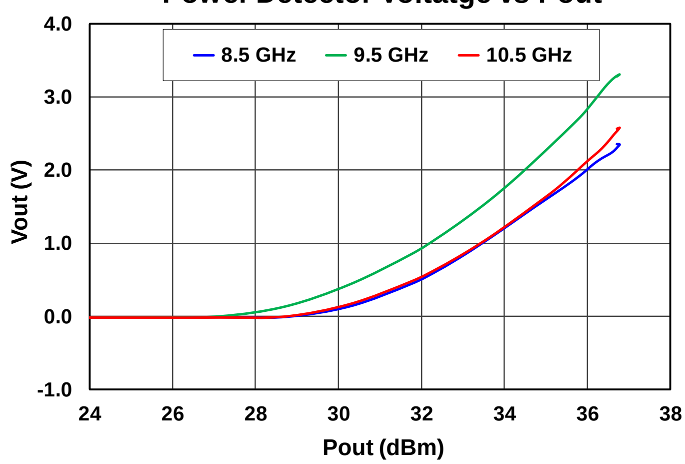
Ids vs Pin



IG vs Pin

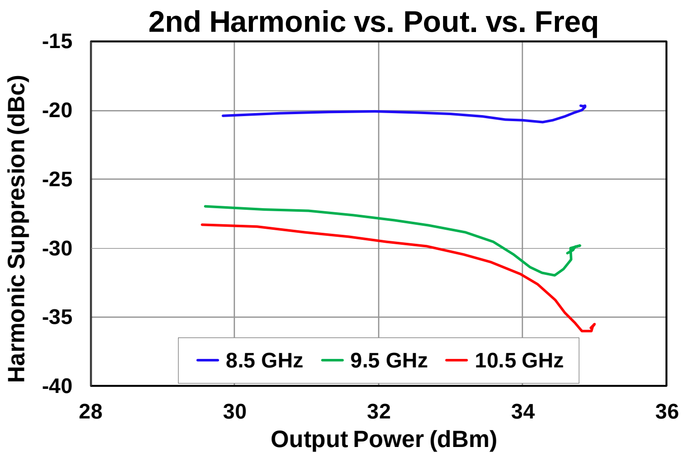


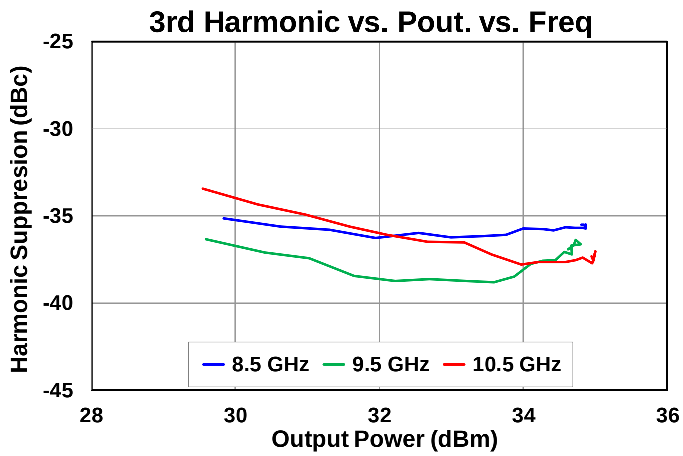
Power Detector Voltatge vs Pout

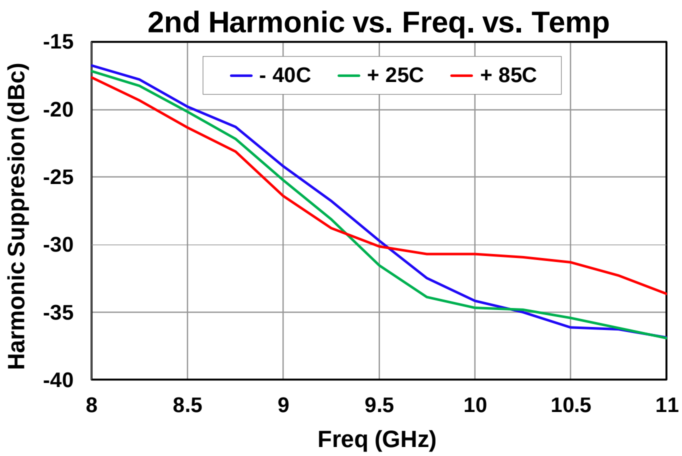


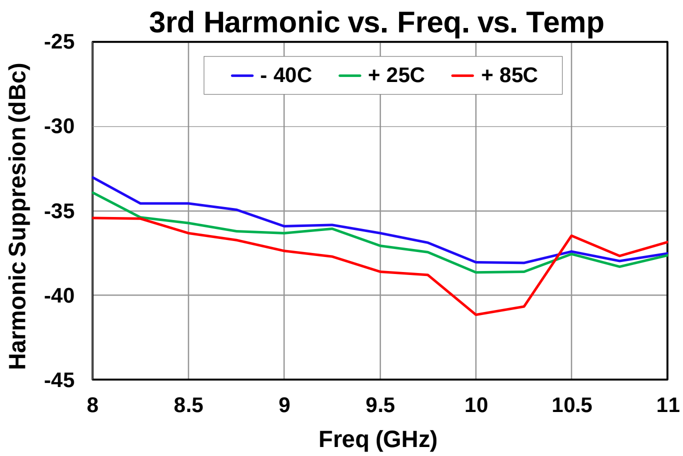
Performance Plots – Harmonic Suppressions, CW

Test conditions otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, Pin = 12 dBm, Temperature = + 25 °C









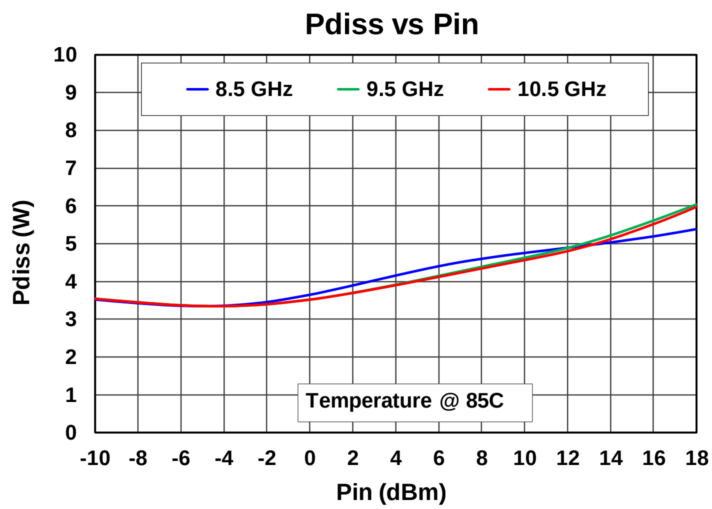
Thermal and Reliability Information

Parameter	Test Conditions	Value	Units
Thermal Resistance (θ_{JC}) (1)	T_{base} = 85 ºC, V_D = 22 V, I_{DQ} = 180 mA, P_{DISS} = 3.96 W, CW, No RF (quiescent DC operation)	8.3	ºC/W
Channel Temperature, T_{CH} (No RF) (2)		118	ºC
Thermal Resistance (θ_{JC}) (1)	T_{base} = 85 ºC, V_D = 22 V, I_{DQ} = 180 mA, CW Freq = 9.5 GHz, I_{D_Drive} = 0.472 A, P_{IN} = 18 dBm, P_{OUT} = 36.4 dBm, P_{DISS} = 6.08 W	9.0	ºC/W
Channel Temperature, T_{CH} (Under RF) (2)		140	ºC

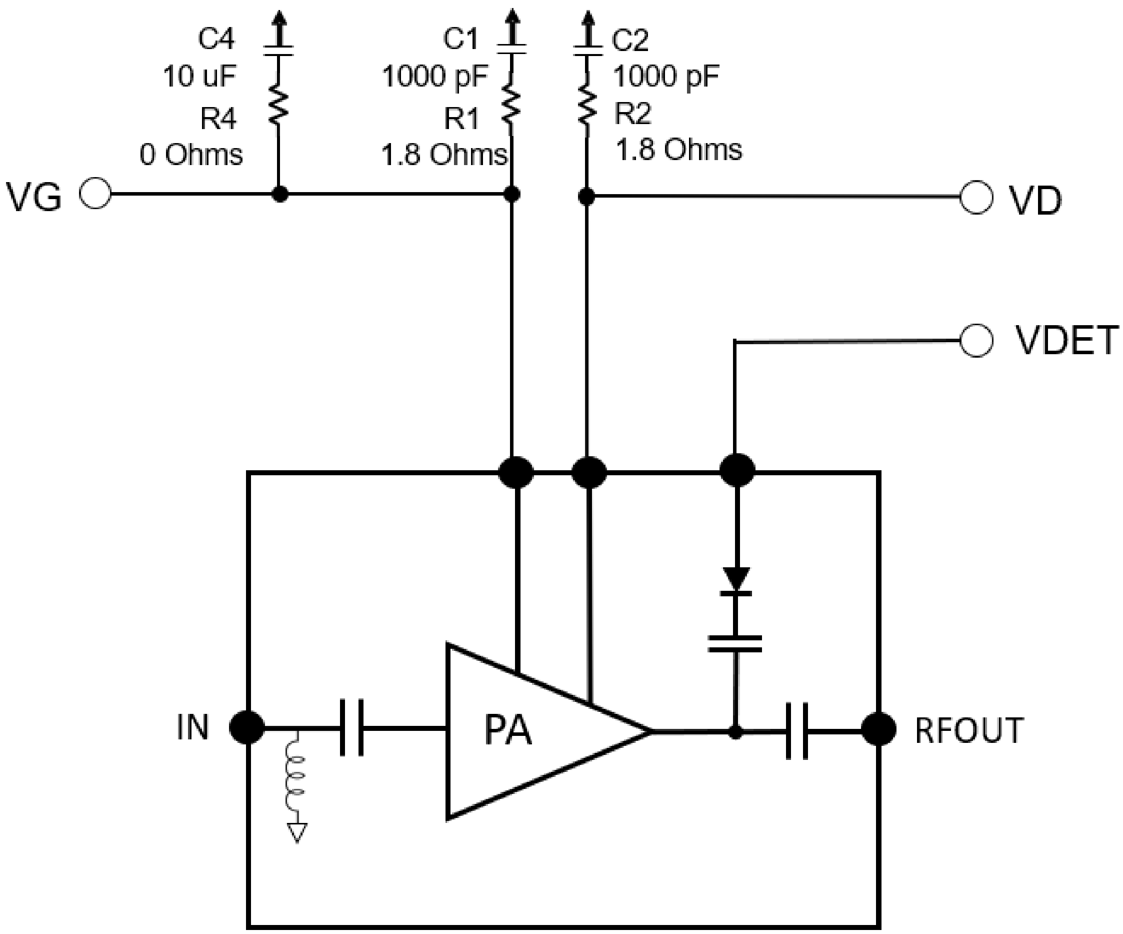
Notes:
1. Thermal resistance is referenced to the back of Cu-Mo carrier plate, assuming carrier thickness 20 mils, eutectic die attachment, back side of carrier temperature at 85 ºC
2. Refer to the following document: GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates

Dissipated Power under RF Drive

Test conditions otherwise noted: V_D = 22 V, I_{DQ} = 180 mA, CW, Temperature = +85 °C



Applications Information



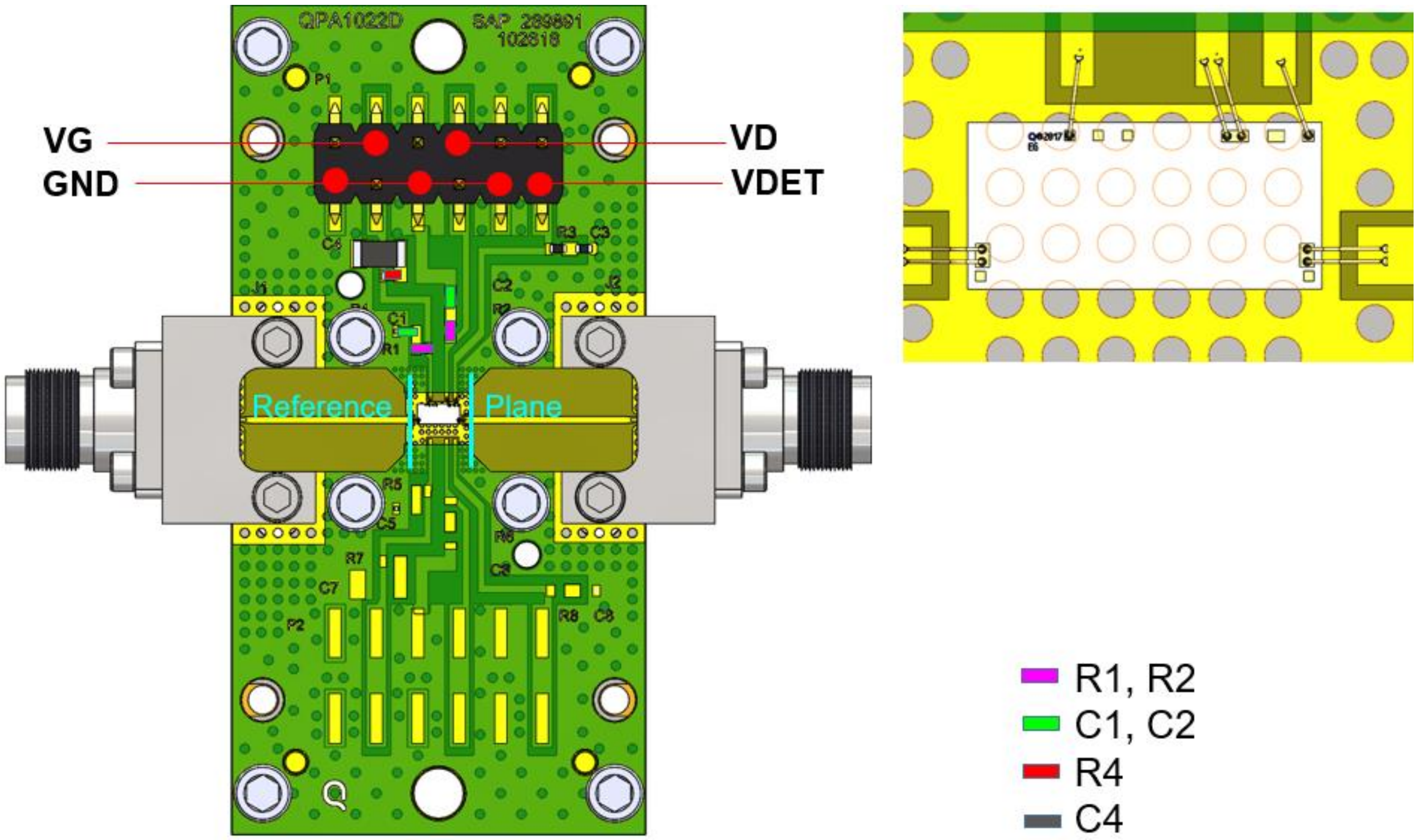
Bias-Up Procedure

1. Set I_D limit to 600 mA, I_G limit to 10 mA
2. Set V_G to −4.0 V
3. Set V_D +22 V
4. Adjust V_G more positive until $I_{DQ} \approx 180$ mA
5. Apply RF signal

Bias-Down Procedure

1. Turn off RF signal
2. Reduce V_G to −4.0 V. Ensure I_{DQ} ~ 0 mA
4. Set V_D to 0 V
5. Turn off V_D supply
6. Turn off V_G supply

Evaluation Board (EVB) Layout Assembly

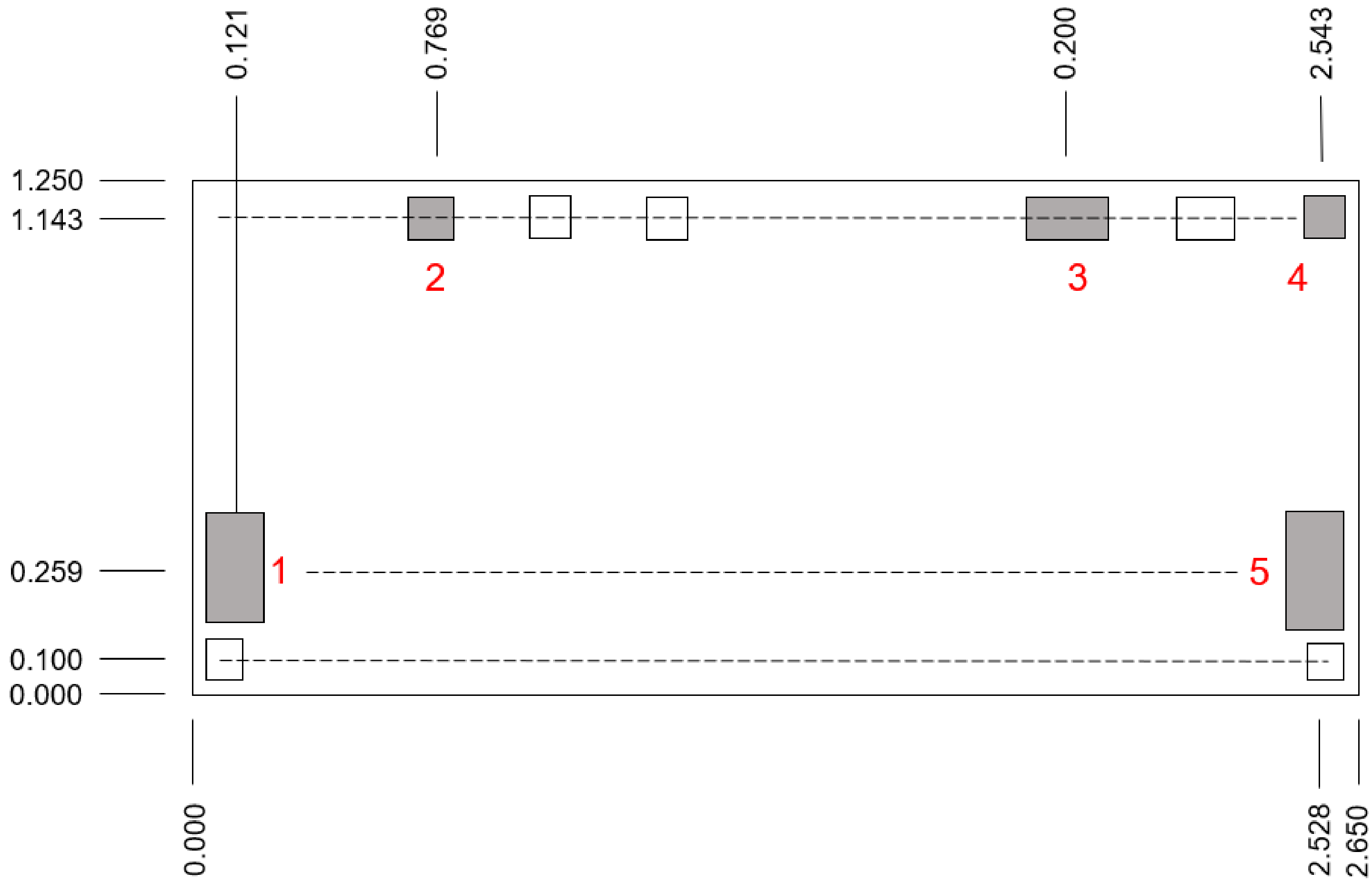


PCB is made from Rogers 4003C dielectric, 8 mil thickness, 0.5 oz. copper both sides.

Bill of Materials

Reference Des.	Value	Description	Manuf.	Part Number
C1, C2	1000 pF	CAP, 1000 pF, 20%, 50 V, 0402	Various	
R1, R2	1.8 Ohm	RES, 1.8 Ohm, 5%, 1/10 W, 0402	Various	
C4	10 uF	CAP, 10 uF, 20%, 50 V, 1206	Various	
R4	0 Ω	RES, 0 OHM, JMPR, 0402	Various	
J1, J2	2.92 mm	CONNECTOR, FEMALE, ENDLAUNCH	Southwest Microwave	1092-01A-5

Mechanical Information



Dimensions are in mm
Die thickness: 0.100
Die x, y size tolerance: ± 0.050
Ground is backside of die

Bond Pad Description

Pad No.	Symbol	Pad Size (mm)	Description
1	RF IN	0.113 x 0.183	RF input. 50 Ohms. DC grounded.
2	VG	0.083 x 0.083	Gate voltage. Bypass network required.
3	VD	0.208 x 0.093	Drain voltage. Bypass network required.
4	VDET	0.090 x 0.090	Power detection. Bias not required.
5	RF OUT	0.113 x 0.183	RF output. 50 Ohms. DC blocked.

Assembly Notes

Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.

Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300 °C to 3 – 4 minutes, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonic are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

Handling Precautions

Parameter	Rating	Standard
ESD – Human Body Model (HBM)	1A	ANSI/ESD/JEDEC JS-001

Caution!

ESD-Sensitive Device

RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A ($C_{15}H_{12}Br_4O_2$) Free
- PFOS Free
- SVHC Free

Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations:

Web: **www.qorvo.com**

Tel: **1-844-890-8163**

Email: **customer.support@qorvo.com**

Important Notice

OCEAN CHIPS
Океан Электроники
Поставка электронных компонентов

Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения **«JONHON»**, а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов **«FORSTAR»**.

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).

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